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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

Naotoshi KIRIHARA et al

Serial No.: 10/593091

Filed: September 15, 2006

For: A LASER IONIZATION MASS
SPECTROMETER

INFORMATION DISCLOSURE STATEMENT

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

As a means of complying with the duty of disclosure under 37 CFR §1.56, and in accordance with 37 CFR §§1.97 and 1.98, Applicant(s), through the undersigned attorney, submits this Information Disclosure Statement. The patents, publications or other information submitted herewith are listed on the attached Form PTO-1449 and copies are attached excluding U.S. patents and publications.

Documents AA and AE-AH listed on the attached Form PTO-1449 were cited in the International Search Report. A copy of the ISR is attached.

Documents AF and AI-AM listed on the attached Form PTO-1449 are discussed on pages 1, 2 and 3 of the instant specification.

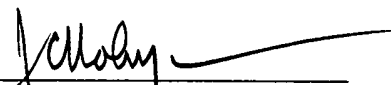
In accordance with 37 CFR §1.97(b)(3), this Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits of the above-identified application.

Should any additional fee be required by the filing of this statement, please charge such fee to Deposit Account No. 06-1358.

Respectfully submitted,

JACOBSON HOLMAN PLLC

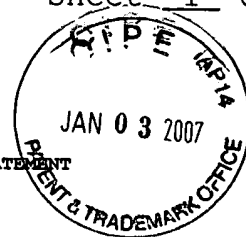
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Date: January 3, 2007

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LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT

ATTY. DOCKET NO.: P71443US0
 SERIAL NO.: 10/593091
 APPLICANT(S): KIRIHARA et al

GROUP ART UNIT: _____
 FILING DATE: September 15, 2006
 TODAY'S DATE: January 3, 2007

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE If Appropriate)
AA	5629518	05/13/97	Grotheer et al	250	288	
AB						
AC						
AD						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES) (NO)
AE	4441972A1	08/14/96	Germany			XX
AF	8-222181	08/30/96	Japan			XX
AG	2001-108657	04/20/01	Japan			XX

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

AH	RIMMPA, 10 th , 2001, pgs. 546-547
AI	Scoles, ATOMIC AND MOLECULAR BEAM METHODS, Basic Techniques, Oxford Univ. Press, 1988, pgs. 62-68
AJ	Smith, Jr. et al, TRANS OF THE ASME, Dec 1962, pgs. 434-446, A Theoretical Method fo Determining Discharge Coefficients for...
AK	Hayes, CHEM. REV. 87, 1987, pgs. 745-760, Analytical Spectroscopy in Supersonic Expansions
AL	Saenger et al, J. CHEM. PHYS. 79, Dec 15, 1983, pgs. 6043-6045, On the time required to reach fully developed flow in pulsed...
AM	Suzuki et al, ANALYTICAL SCI. 2001, Vol 17 Suppl., pgs. i563-I-566, A New Laser Mass Spectrometry for Chemical Ultratrace...

EXAMINER

DATE CONSIDERED

* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s)